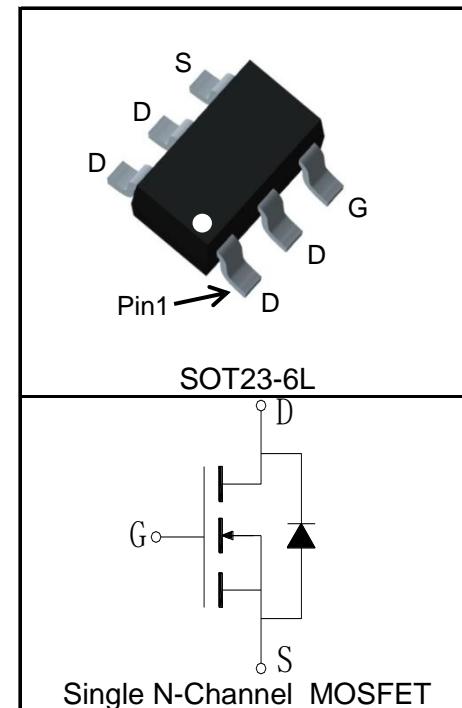


Features

- 30V/7A,
- $R_{DS(ON)} = 16\text{m}\Omega(\text{Typ.}) @ V_{GS} = 10\text{V}$
- $R_{DS(ON)} = 20\text{m}\Omega(\text{Typ.}) @ V_{GS} = 4.5\text{V}$
- Low $R_{DS(ON)}$
- Super High Dense Cell Design
- Reliable and Rugged

Pin Description



Applications

- Load Switch



Halogen-Free

Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit
Common Ratings ($T_A = 25^\circ\text{C}$ Unless Otherwise Noted)			
V_{DSS}	Drain-Source Voltage	30	V
V_{GSS}	Gate-Source Voltage	± 20	
T_J	Maximum Junction Temperature	150	$^\circ\text{C}$
T_{STG}	Storage Temperature Range	-55 to 150	$^\circ\text{C}$
I_S	Diode Continuous Forward Current	$T_A = 25^\circ\text{C}$	1.6
			A

Mounted on Large Heat Sink

$I_{DP}^{①}$	300 μs Pulse Drain Current Tested	$T_A = 25^\circ\text{C}$	28	A
$I_D^{②}$	Continuous Drain Current($V_{GS} = 10\text{V}$)	$T_A = 25^\circ\text{C}$	7	A
		$T_A = 70^\circ\text{C}$	5.6	
P_D	Maximum Power Dissipation	$T_A = 25^\circ\text{C}$	1.3	W
		$T_A = 70^\circ\text{C}$	0.8	
$R_{\theta JL}$	Thermal Resistance-Junction to Lead		60	$^\circ\text{C/W}$
$R_{\theta JA}^{③}$	Thermal Resistance-Junction to Ambient		100	$^\circ\text{C/W}$

Drain-Source Avalanche Ratings

$E_{AS}^{④}$	Avalanche Energy, Single Pulsed	9	mJ
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Electrical Characteristics ($T_A=25^\circ\text{C}$ Unless Otherwise Noted)

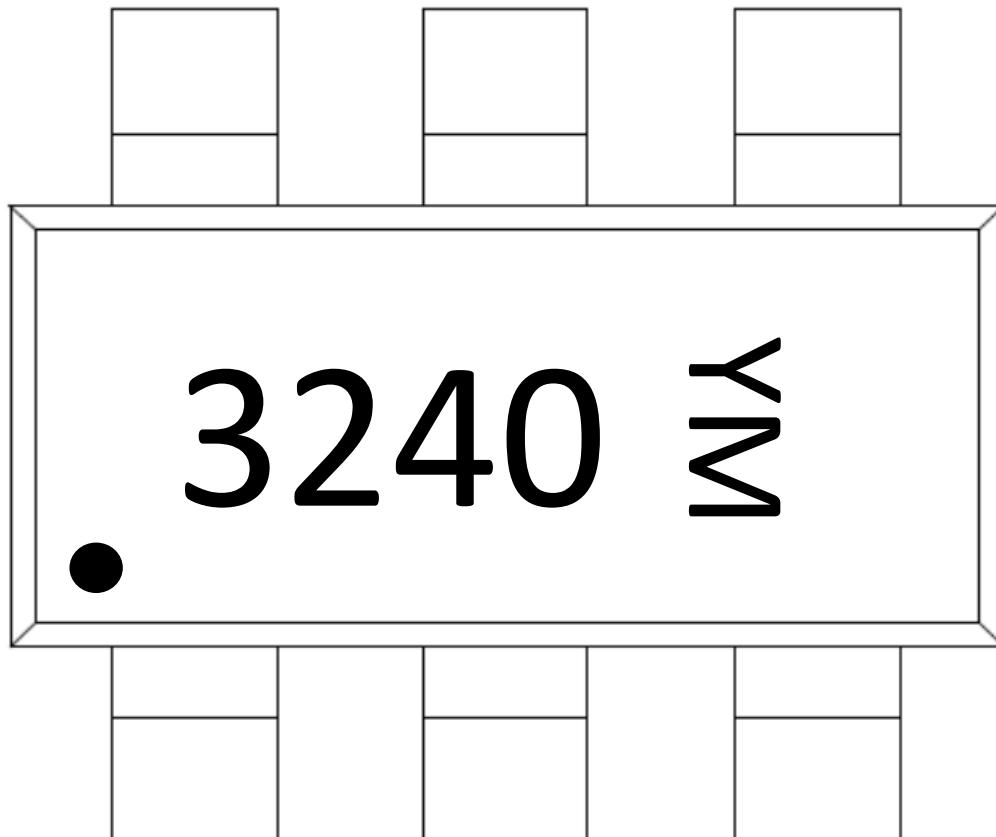
Symbol	Parameter	Test Condition	KS3240EA6			Unit
			Min.	Typ.	Max.	
Diode Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_{\text{DS}}=250\mu\text{A}$	30			V
I_{DSS}	Zero Gate Voltage Drain Current	$\text{V}_{\text{DS}}=30\text{V}, \text{V}_{\text{GS}}=0\text{V}$			1	μA
		$\text{T}_J=125^\circ\text{C}$			30	
$\text{V}_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_{\text{DS}}=250\mu\text{A}$	1.1	1.6	2.3	V
I_{GSS}	Gate Leakage Current	$\text{V}_{\text{GS}}=\pm 20\text{V}, \text{V}_{\text{DS}}=0\text{V}$			± 100	nA
$\text{R}_{\text{DS}(\text{ON})}^{(5)}$	Drain-Source On-state Resistance	$\text{V}_{\text{GS}}=10\text{V}, \text{I}_{\text{DS}}=6\text{A}$		16	20	$\text{m}\Omega$
		$\text{V}_{\text{GS}}=4.5\text{V}, \text{I}_{\text{DS}}=4\text{A}$		20	26	$\text{m}\Omega$
Dynamic Characteristics ⁽⁶⁾						
R_G	Gate Resistance	$\text{V}_{\text{GS}}=0\text{V}, \text{V}_{\text{DS}}=0\text{V}, \text{F}=1\text{MHz}$		2		Ω
C_{iss}	Input Capacitance	$\text{V}_{\text{GS}}=0\text{V}, \text{V}_{\text{DS}}=15\text{V}, \text{Frequency}=1.0\text{MHz}$		455		pF
C_{oss}	Output Capacitance			75		
C_{rss}	Reverse Transfer Capacitance			60		
$t_{\text{d}(\text{ON})}$	Turn-on Delay Time	$\text{V}_{\text{DD}}=15\text{V}, \text{I}_{\text{DS}}=6\text{A}, \text{V}_{\text{GEN}}=10\text{V}, \text{R}_G=6\Omega$		6		ns
t_r	Turn-on Rise Time			11		
$t_{\text{d}(\text{OFF})}$	Turn-off Delay Time			20		
t_f	Turn-off Fall Time			8		
Gate Charge Characteristics ⁽⁶⁾						
Q_g	Total Gate Charge	$\text{V}_{\text{DS}}=15\text{V}, \text{V}_{\text{GS}}=10\text{V}, \text{I}_{\text{DS}}=6\text{A}$		10		nC
Q_{gs}	Gate-Source Charge			2.8		
Q_{gd}	Gate-Drain Charge			3.7		

Notes:

- ①Pulse width limited by safe operating area.
- ②Calculated continuous current based on maximum allowable junction temperature. The package limitation current is 6.5A.
- ③When mounted on 1 inch square copper board, $t \leq 10\text{sec}$. The value in any given application depends on the user's specific board design.
- ④Limited by $\text{T}_{\text{Jmax}}, \text{I}_{\text{AS}} = 6\text{A}, \text{L}=0.5\text{mH}, \text{V}_{\text{DD}} = 10\text{V}, \text{R}_G = 25\Omega$, Starting $\text{T}_J = 25^\circ\text{C}$.
- ⑤Pulse test; Pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.
- ⑥Guaranteed by design, not subject to production testing.

Ordering and Marking Information

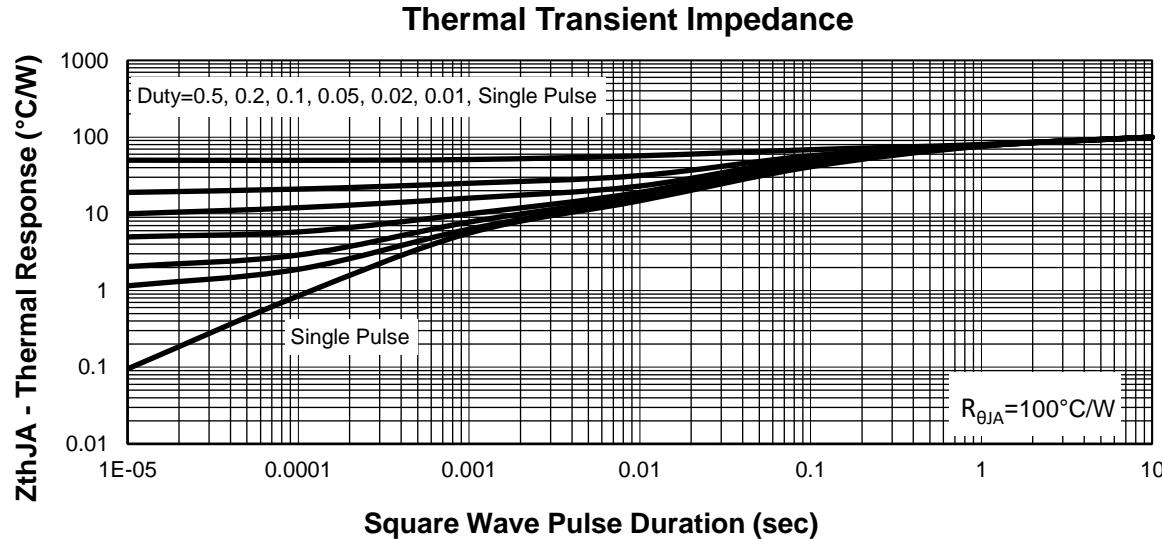
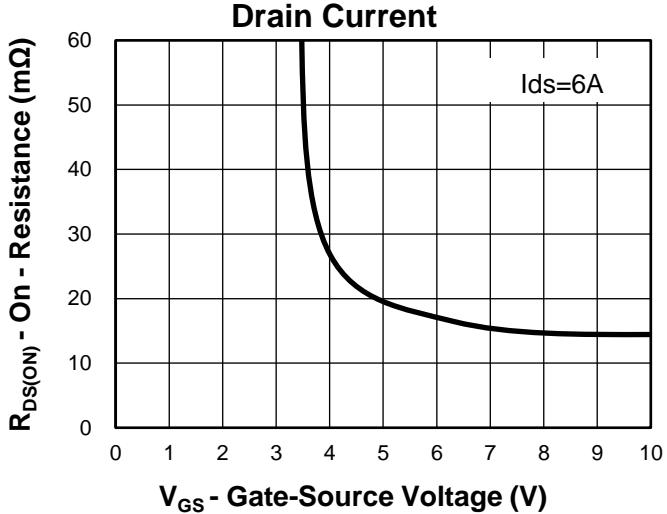
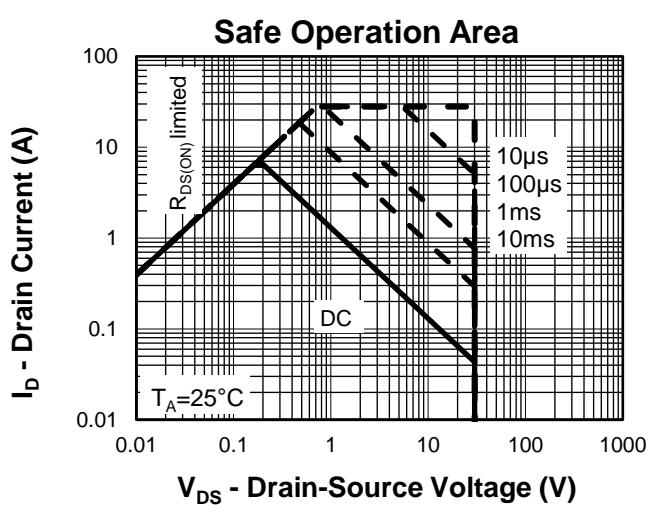
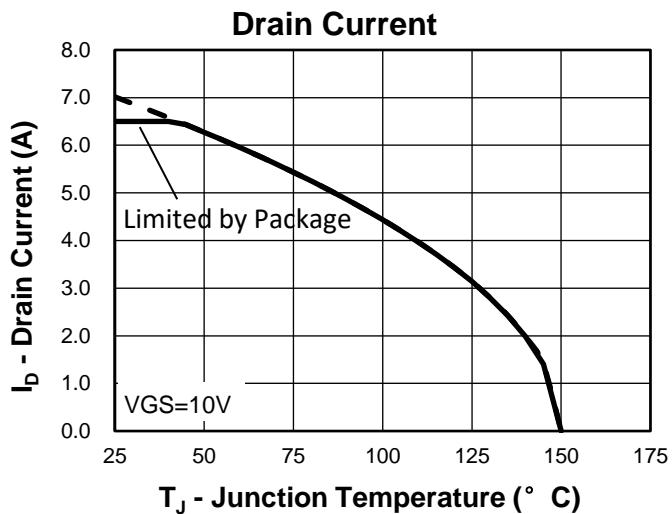
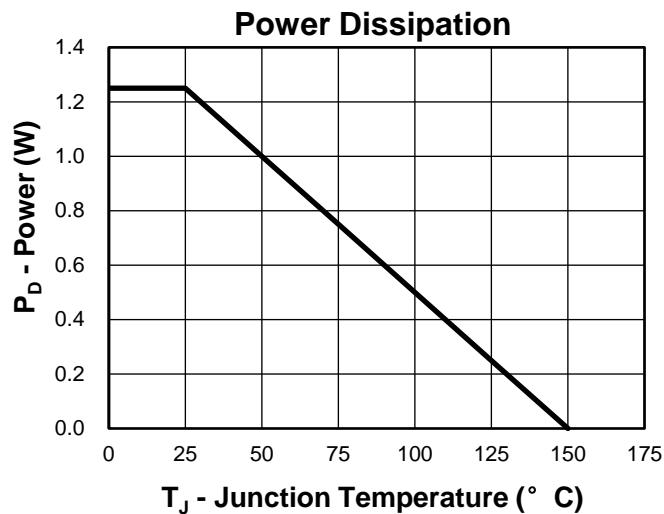
Device	Package	Packaging	Quantity	Reel Size	Tape width
KS3240EA6	SOT23-6L	Tape&Reel	3000	7"	8mm



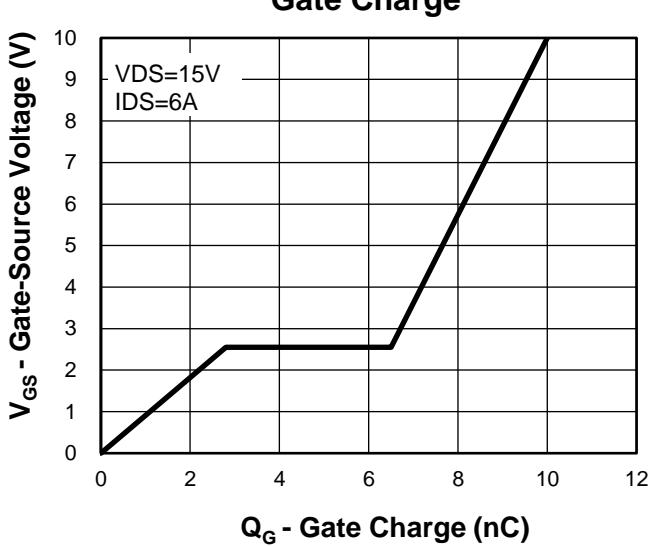
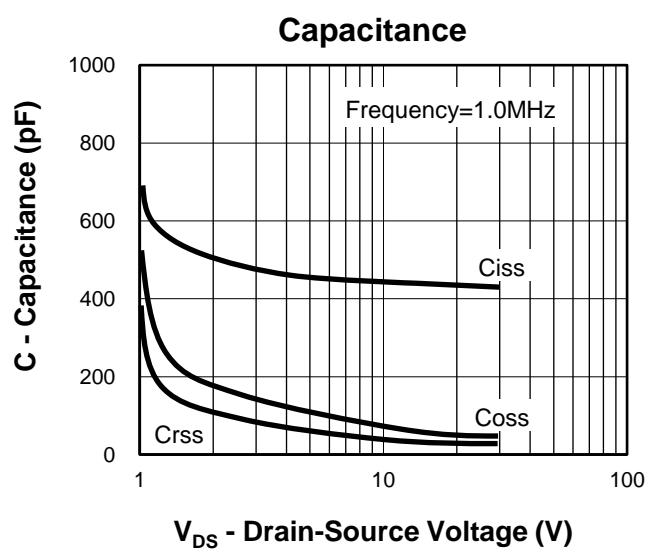
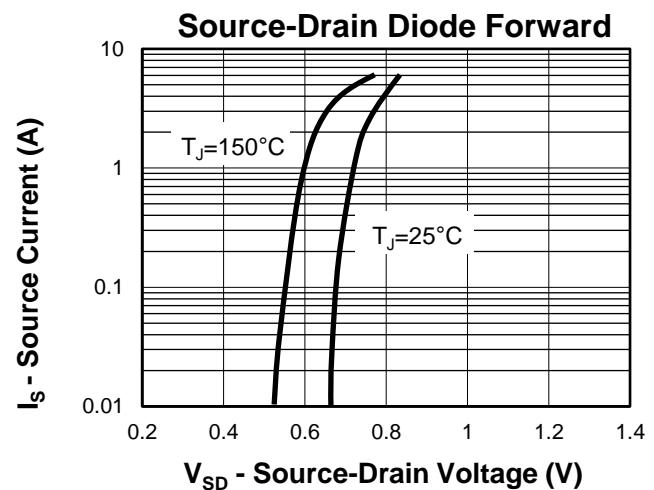
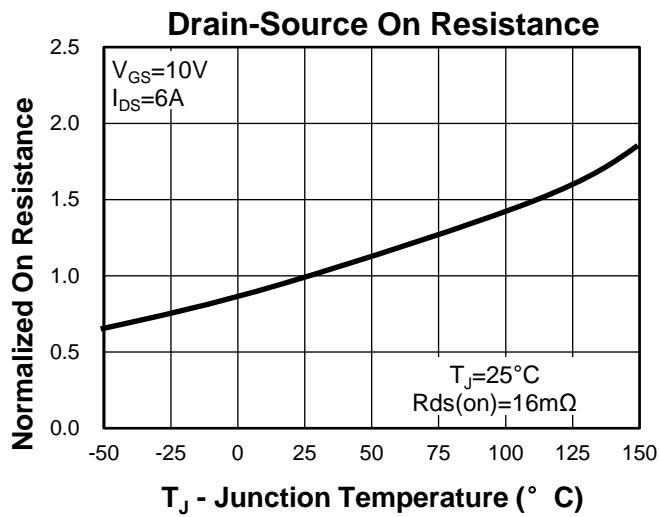
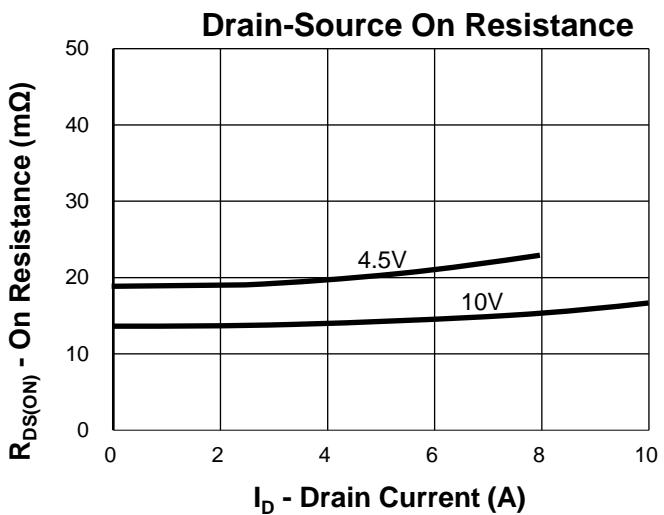
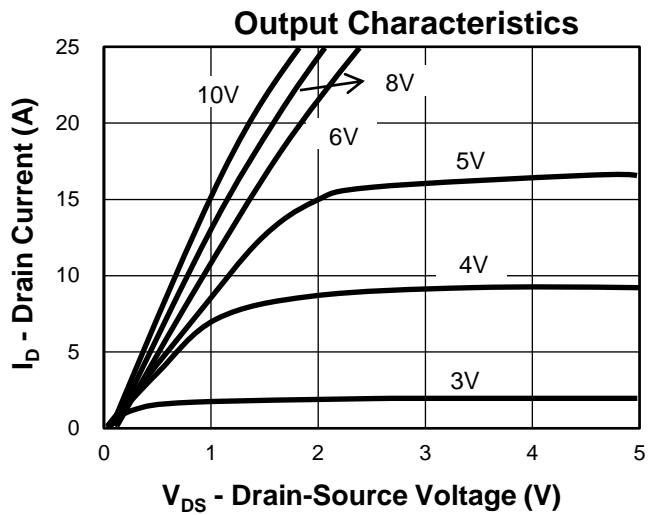
Y =Year,2017-A,2018-B,etc.

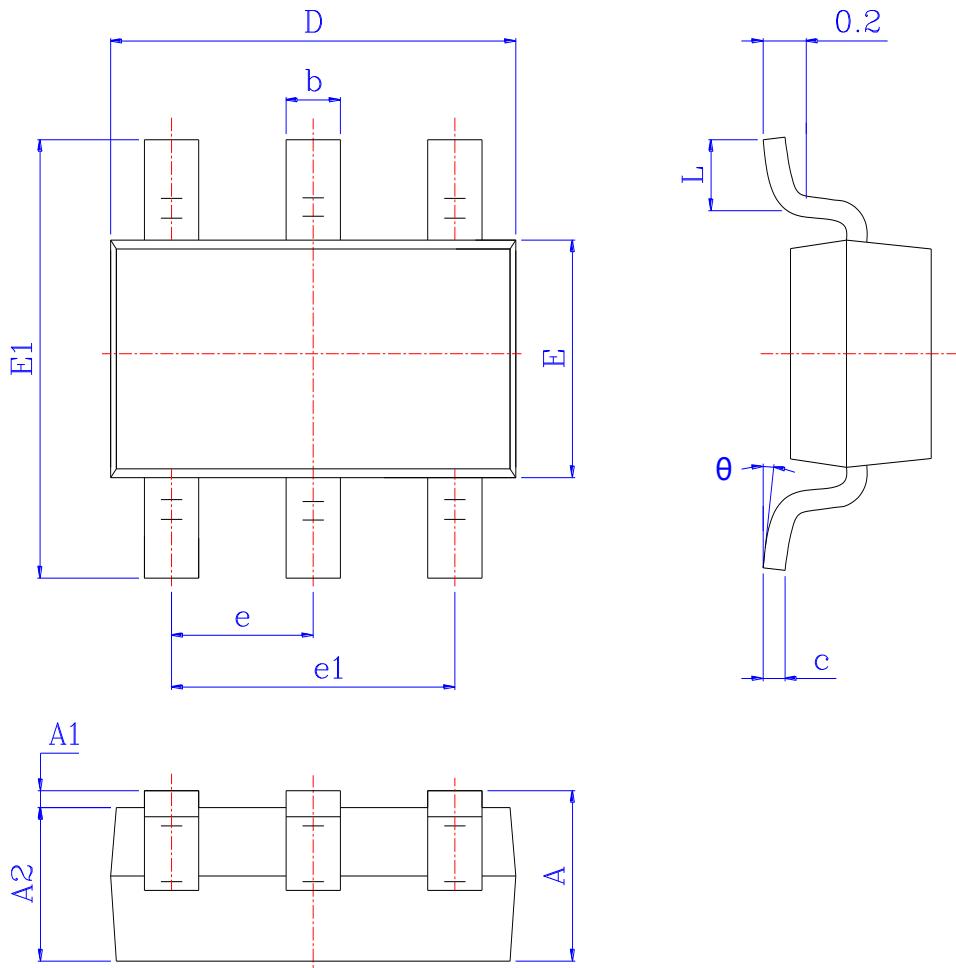
M =Month,Jan-1,Feb-2,...,Sep-9,Oct-A,Nov-B,Dec-C.

Typical Characteristics



Typical Characteristics



Package Information
SOT23-6L


SYMBOL	MM			INCH		
	MIN	NOM	MAX	MIN	NOM	MAX
A	0.950	1.150	1.450	0.037	0.045	0.057
A1	0.000	0.060	0.150	0.000	0.002	0.006
A2	0.900	1.100	1.300	0.035	0.043	0.051
b	0.300	0.400	0.500	0.012	0.016	0.020
c	0.080	0.140	0.200	0.003	0.006	0.008
D	2.800	2.900	3.050	0.110	0.114	0.120
E	1.500	1.600	1.750	0.059	0.063	0.069
E1	2.600	2.800	3.000	0.102	0.110	0.118
e	0.950BSC			0.037BSC		
e1	1.800	1.900	2.000	0.071	0.075	0.079
L	0.300	0.450	0.600	0.012	0.018	0.024
θ	0°	4°	8°	0°	4°	8°

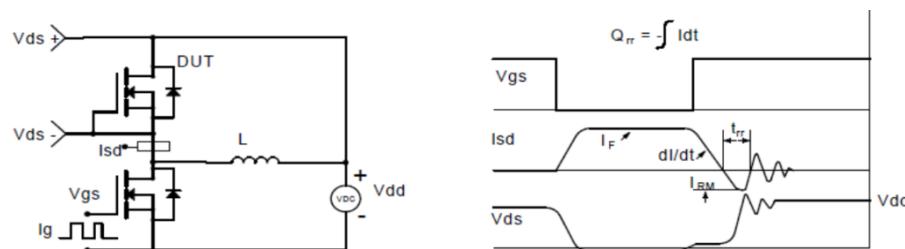
Avalanche Test Circuit and Waveforms



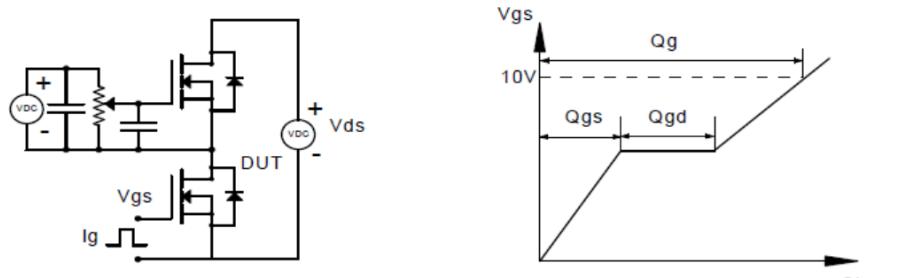
Switching Time Test Circuit and Waveforms



Diode Recovery Test Circuit and Waveforms



Gate Charge Test Circuit and Waveform



Customer Service

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